

Component Parameter Test Instruments

A. TH283X Series Compact LCR Meter

Features

- Low cost, high performance, small size
- 4.3 inch TFT LCD Display
- Soft power switch
- Selectable Chinese-English operation language
- Max. 200kHz test frequency
- Max. 6 digit reading resolution
- 10mVrms-2.0Vrms programmable signal level,
built-in 0 - \pm 5V/50mA bias source
- DCR, 50mV-2V programmable test level, resolution 10 μ Ω
- Ls-Rd / Lp-Rd Function (L, Rd display simultaneously) *
- Highest test speed 13ms/time
- Selectable 30 Ω /100 Ω signal source impedance
- V/I monitor and auto level adjustment function
- Built-in comparator, 10 bins sorting and count function
- File storage and firmware update through U disk
- RS232, RS485, USB, HANDLER, GPIB interface

* Rd means DCR.



TH283X Series

Rack mount (mm): 215(W) x 88(H) x 335(D)
Dimension (mm): 235(W) x 105(H) x 360(D)
Net weight: 3.6 kg

Brief Introduction

■ Adopting the latest technology & high density circuit design and concentrating the essence of LCR test, TH283X series is a new generation compact LCR meter of low cost and high performance. Instead of traditional mechanical power switch, it adopts software control power switch. The basic accuracy of 0.05% and good test stability can compare favourably with those high-end models. Being equipped with 4.3 inch TFT LCD Display and brand new interface system, TH283X series LCR meters possess elegant appearance and easy operation. Also, being provided with various interfaces and good compatibility with SCPI commands, TH283X series LCR meters are convenient for constituting all kinds of test system and satisfy various kinds of demands for inspection, production and scientific research.

Specifications

Model		TH2830	TH2831	TH2832
Basic measurement accuracy (See details in technical specification)	LCRZ	0.05%	0.1%	0.05%
	DCR	0.1%		
	Calibration condition	Warm up time: \geq 30 minutes ; Environment temperature: 23 \pm 5 $^{\circ}$ C Signal level: 1Vrms ; Correction: after OPEN, SHORT Testing cable length: 0 m		
Test signal frequency		50Hz-100kHz , 34points 50Hz, 60Hz, 75Hz, 100Hz,120Hz,150Hz,200Hz,250Hz,300Hz, 400Hz,500Hz,600Hz,750Hz,1kHz,1.2kHz, 1.5kHz,2kHz, 2.5kHz, 3kHz, 4kHz,5kHz, 6kHz,7.5kHz,10kHz,12kHz,15kHz,20kHz, 25kHz,30kHz,40kHz,50kHz,60kHz,75kHz, 100kHz	50Hz-200kHz , 37 points 50Hz, 60Hz, 75Hz, 100Hz, 120Hz,150Hz,200Hz,250Hz, 300Hz,400Hz,500Hz,600Hz, 750Hz,1kHz,1.2kHz,1.5kHz, 2kHz, 2.5kHz, 3kHz, 4kHz, 5kHz, 6kHz, 7.5kHz,10kHz, 12kHz,15kHz,20kHz,25kHz, 30kHz,40kHz,50kHz,60kHz, 75kHz,100kHz,120kHz,150kHz, 200kHz	20Hz-200kHz , 15025 points
Signal source output impedance		Selectable 30 Ω , 100 Ω , \pm 1% @1kHz		

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AC test signal level	Normal	10mV—2Vrms																																						
		Resolution: 10mV, Accuracy: 10% x setting voltage+2mV																																						
	Constant level (ALC ON)	100μA—20mArms																																						
		Resolution: 0.1mA																																						
DCR test signal level	Constant level (ALC ON)	-----	-----	20mV—1Vrms																																				
		-----	-----	Resolution: 10mV Accuracy: 10%																																				
		-----	-----	200μA—10mArms																																				
		-----	-----	Resolution: 0.1mA																																				
DCR test signal level	Constant level (ALC ON)	1V DC	1V DC	50mV—2V DC																																				
		-----	-----	Resolution: 0.5mV																																				
DC bias voltage source	Constant level (ALC ON)	-----	-----	0V— ± 5V																																				
		-----	-----	Resolution: 0.5mV, Accuracy: 1%																																				
		-----	-----	0mA—± 50mA																																				
		-----	-----	Resolution: 0.5μA																																				
Test parameters	Z , Y , C, L, X, B, R, G, D, Q, θ, DCR																																							
DCR display range	0.00001 Ω – 99.9999 MΩ																																							
LCR parameters display range	<table border="0"> <tr> <td> Z , R, X</td> <td>0.00001Ω</td> <td>—</td> <td>99.9999MΩ</td> </tr> <tr> <td> Y , G, B</td> <td>0.00001μs</td> <td>—</td> <td>99.9999s</td> </tr> <tr> <td>C</td> <td>0.00001pF</td> <td>—</td> <td>9.99999F</td> </tr> <tr> <td>L</td> <td>0.00001μH</td> <td>—</td> <td>99.9999kH</td> </tr> <tr> <td>D</td> <td>0.00001</td> <td>—</td> <td>9.99999</td> </tr> <tr> <td>Q</td> <td>0.00001</td> <td>—</td> <td>99999.9</td> </tr> <tr> <td>θ(DEG)</td> <td>-179.999°</td> <td>—</td> <td>179.999°</td> </tr> <tr> <td>θ(RAD)</td> <td>-3.14159</td> <td>—</td> <td>3.14159</td> </tr> <tr> <td>Δ%</td> <td>-999.999%</td> <td>—</td> <td>999.999%</td> </tr> </table>				Z , R, X	0.00001Ω	—	99.9999MΩ	Y , G, B	0.00001μs	—	99.9999s	C	0.00001pF	—	9.99999F	L	0.00001μH	—	99.9999kH	D	0.00001	—	9.99999	Q	0.00001	—	99999.9	θ(DEG)	-179.999°	—	179.999°	θ(RAD)	-3.14159	—	3.14159	Δ%	-999.999%	—	999.999%
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Δ%	-999.999%	—	999.999%																																					
Display digits	6	5	6																																					
Measurement time (≥10 kHz)	Fast: 75 meas/sec(13ms), Medium:11 meas/sec(90 ms), Slow: 2.7meas/sec(370 ms)																																							
Equivalent circuit	Serial, Parallel																																							
Range mode	Auto, Hold																																							
Trigger mode	Internal, Manual, External, Bus																																							
Average time	1–255																																							
Correction	Open, Short, Load																																							
Math operation	Direct reading, ΔABS, Δ%																																							
Trigger delay time setting	0 - 60.000s, 1ms steps																																							
Step delay time setting	0 - 60.000s, 1ms steps																																							
List Sweep	<ul style="list-style-type: none"> ·10 points list sweep ·Frequency, AC voltage/current, internal/ external bias voltage/ current can be swept. ·Each sweep point can be sorted separately. 																																							
Comparator function	10 bins, BIN1–BIN9, NG, AUX																																							
	Bin count function																																							
	PASS, FAIL LED display on front panel																																							
Built-in Storage	Internal 100 LCRZ instrument setting files, 201 times test results																																							
USB Storage	Instrument setting files , measurement result CSV files, printed screen (GIF format)																																							
Interface	Control interface	HANDLER																																						
	Communication interface	USB HOST, RS232C, RS485(option), GPIB(option)																																						
	Storage interface	USB DEVICE (U-disk storage)																																						